

Notice of References Cited		Application/Control No. 10/785,404	Applicant(s)/Patent Under Reexamination LEE, SANG-HAK	
		Examiner OLUWASEUN A. ADEGEYE	Art Unit 2621	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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